

### General Description

- Trench Power MOSFET technology
- Low  $R_{DS(ON)}$
- Low Gate Charge
- High Current Capability
- RoHS and Halogen-Free Compliant

### Applications

- DC/DC Converters in Computing
- POL in Telecom and Industrial

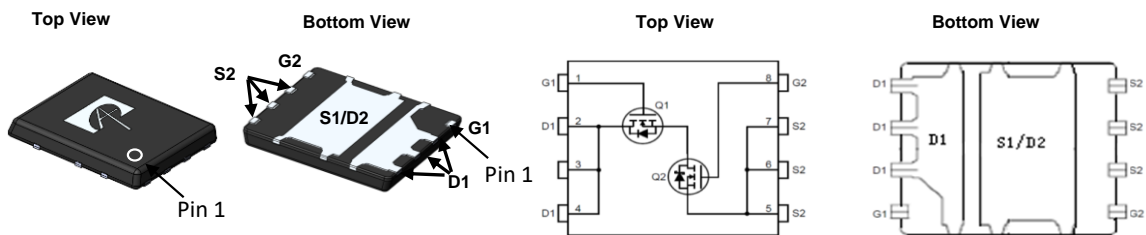
### Product Summary

|                                  | <u>Q1</u>      | <u>Q2</u>      |
|----------------------------------|----------------|----------------|
| $V_{DS}$                         | 30V            | 30V            |
| $I_D$ (at $V_{GS}=10V$ )         | 51A            | 85A            |
| $R_{DS(ON)}$ (at $V_{GS}=10V$ )  | <5.2m $\Omega$ | <2.8m $\Omega$ |
| $R_{DS(ON)}$ (at $V_{GS}=4.5V$ ) | <8.6m $\Omega$ | <3.5m $\Omega$ |

100% UIS Tested  
 100% Rg Tested



### DFN 5X6D



| Orderable Part Number | Package Type | Form        | Minimum Order Quantity |
|-----------------------|--------------|-------------|------------------------|
| AONY36304             | DFN 5x6D     | Tape & Reel | 3000                   |

### Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

| Parameter                                       | Symbol         | Max Q1     | Max Q2   | Units            |
|---|----------------|------------|----------|------------------|
| Drain-Source Voltage                            | $V_{DS}$       | 30         | 30       | V                |
| Gate-Source Voltage                             | $V_{GS}$       | $\pm 20$   | $\pm 12$ | V                |
| Continuous Drain Current                        | $I_D$          | 51         | 83       | A                |
| $T_C=100^\circ\text{C}$                         |                | 32         | 52       |                  |
| Pulsed Drain Current <sup>C</sup>               | $I_{DM}$       | 110        | 180      |                  |
| Continuous Drain Current                        | $I_{DSM}$      | 20         | 26       | A                |
| $T_A=70^\circ\text{C}$                          |                | 16         | 21       |                  |
| Avalanche Current <sup>C</sup>                  | $I_{AS}$       | 50         | 75       | A                |
| Avalanche energy $L=0.01\text{mH}$ <sup>C</sup> | $E_{AS}$       | 12.5       | 28       | mJ               |
| Power Dissipation <sup>B</sup>                  | $P_D$          | 21         | 31.5     | W                |
| $T_C=100^\circ\text{C}$                         |                | 8.5        | 12.5     |                  |
| Power Dissipation <sup>A</sup>                  | $P_{DSM}$      | 3.1        | 3.1      | W                |
| $T_A=70^\circ\text{C}$                          |                | 2          | 2        |                  |
| Junction and Storage Temperature Range          | $T_J, T_{STG}$ | -55 to 150 |          | $^\circ\text{C}$ |

### Thermal Characteristics

| Parameter  | Symbol          | Typ Q1 | Typ Q2 | Max Q1 | Max Q2 | Units              |
|--|-----------------|--------|--------|--------|--------|--------------------|
| Maximum Junction-to-Ambient <sup>A</sup> $t \leq 10\text{s}$ | $R_{\theta JA}$ | 30     | 30     | 40     | 40     | $^\circ\text{C/W}$ |
| Maximum Junction-to-Ambient <sup>A,D</sup> Steady-State      |                 | 50     | 50     | 65     | 65     | $^\circ\text{C/W}$ |
| Maximum Junction-to-Case Steady-State                        | $R_{\theta JC}$ | 4.6    | 3.1    | 6      | 4      | $^\circ\text{C/W}$ |

**Q1 Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)**

| Symbol                      | Parameter                             | Conditions   | Min | Typ  | Max    | Units |
|-----------------------------|---------------------------------------|--|-----|------|--------|-------|
| <b>STATIC PARAMETERS</b>    |                                       |  |     |      |        |       |
| BV <sub>DSS</sub>           | Drain-Source Breakdown Voltage        | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V   | 30  |      |        | V     |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current       | V <sub>DS</sub> =30V, V <sub>GS</sub> =0V<br>T <sub>J</sub> =55°C                          |     |      | 1<br>5 | μA    |
| I <sub>GSS</sub>            | Gate-Body leakage current             | V <sub>DS</sub> =0V, V <sub>GS</sub> =±20V   |     |      | ±100   | nA    |
| V <sub>GS(th)</sub>         | Gate Threshold Voltage                | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA                                   | 1.3 | 1.75 | 2.2    | V     |
| R <sub>DS(ON)</sub>         | Static Drain-Source On-Resistance     | V <sub>GS</sub> =10V, I <sub>D</sub> =20A<br>T <sub>J</sub> =125°C                         |     | 3.8  | 5.2    | mΩ    |
|                             |                                       | V <sub>GS</sub> =4.5V, I <sub>D</sub> =20A   |     | 5.4  | 7.6    |       |
| g <sub>FS</sub>             | Forward Transconductance              | V <sub>DS</sub> =5V, I <sub>D</sub> =20A   |     | 80   |        | S     |
| V <sub>SD</sub>             | Diode Forward Voltage                 | I <sub>S</sub> =1A, V <sub>GS</sub> =0V  |     | 0.7  | 1      | V     |
| I <sub>S</sub>              | Maximum Body-Diode Continuous Current |  |     |      | 30     | A     |
| <b>DYNAMIC PARAMETERS</b>   |                                       |  |     |      |        |       |
| C <sub>iss</sub>            | Input Capacitance                     | V <sub>GS</sub> =0V, V <sub>DS</sub> =15V, f=1MHz  |     | 1000 |        | pF    |
| C <sub>oss</sub>            | Output Capacitance                    |  |     | 290  |        | pF    |
| C <sub>rss</sub>            | Reverse Transfer Capacitance          |  |     | 50   |        | pF    |
| R <sub>g</sub>              | Gate resistance                       | f=1MHz   | 0.2 | 0.6  | 1      | Ω     |
| <b>SWITCHING PARAMETERS</b> |                                       |  |     |      |        |       |
| Q <sub>g</sub> (10V)        | Total Gate Charge                     | V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, I <sub>D</sub> =20A                            |     | 17   | 30     | nC    |
| Q <sub>g</sub> (4.5V)       | Total Gate Charge                     |  |     | 8    | 15     |       |
| Q <sub>gs</sub>             | Gate Source Charge                    |  |     | 2.8  |        |       |
| Q <sub>gd</sub>             | Gate Drain Charge                     |  |     | 4.1  |        |       |
| t <sub>D(on)</sub>          | Turn-On Delay Time                    | V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, R <sub>L</sub> =0.75Ω,<br>R <sub>GEN</sub> =3Ω |     | 7    |        | ns    |
| t <sub>r</sub>              | Turn-On Rise Time                     |  |     | 3    |        |       |
| t <sub>D(off)</sub>         | Turn-Off Delay Time                   |  |     | 19   |        |       |
| t <sub>f</sub>              | Turn-Off Fall Time                    |  |     | 2.5  |        |       |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time      | I <sub>F</sub> =20A, di/dt=500A/μs   |     | 11   |        | ns    |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery Charge    | I <sub>F</sub> =20A, di/dt=500A/μs   |     | 19   |        | nC    |

A. The value of R<sub>θJA</sub> is measured with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub> = 25° C. The Power dissipation P<sub>DSM</sub> is based on R<sub>θJA</sub> ≤ 10s and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design.

B. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature T<sub>J(MAX)</sub>=150° C.

D. The R<sub>θJA</sub> is the sum of the thermal impedance from junction to case R<sub>θJC</sub> and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150° C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

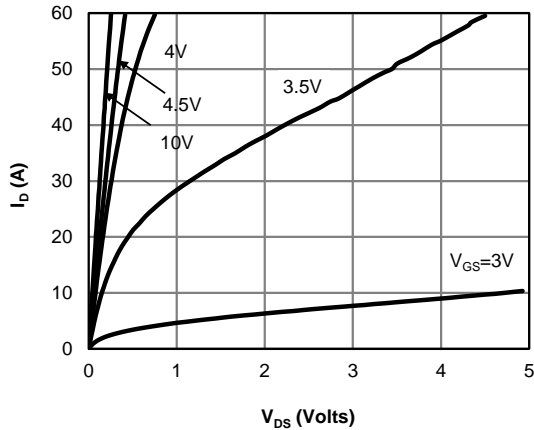
H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C.

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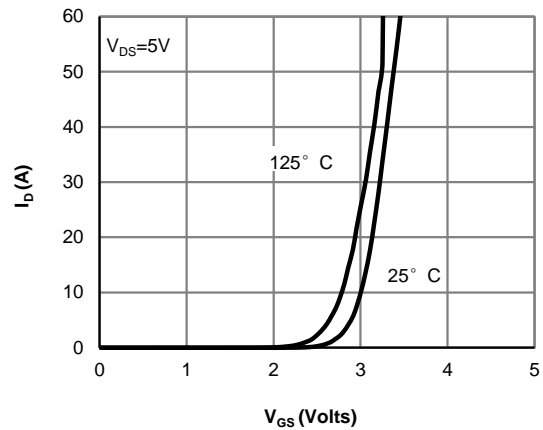
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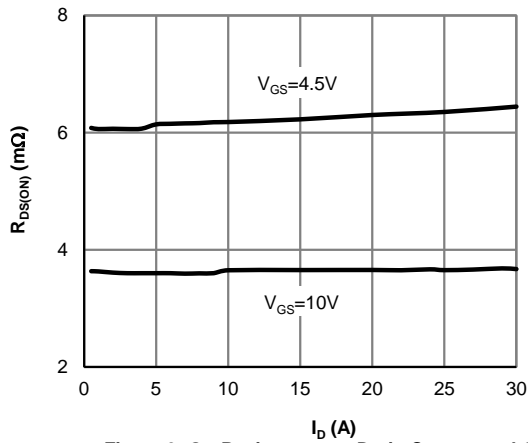
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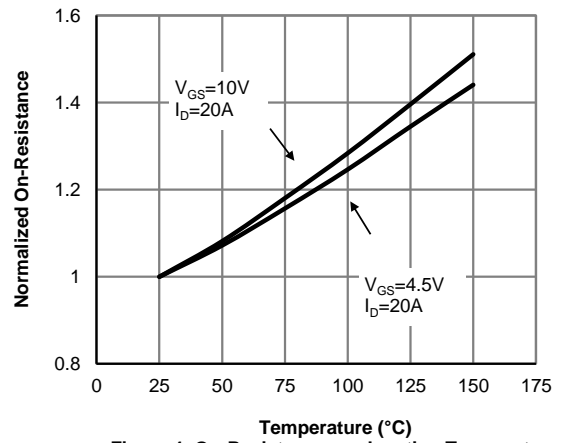
**Figure 1: On-Region Characteristics (Note E)**



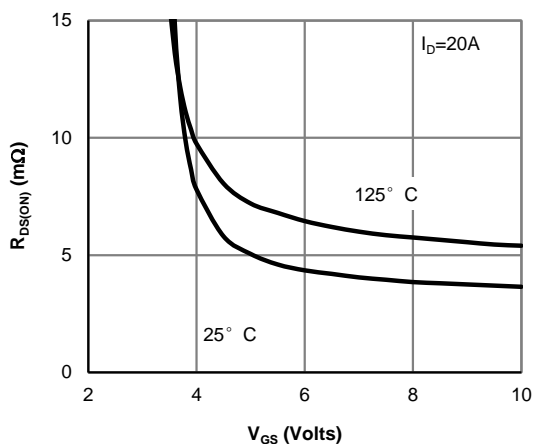
**Figure 2: Transfer Characteristics (Note E)**



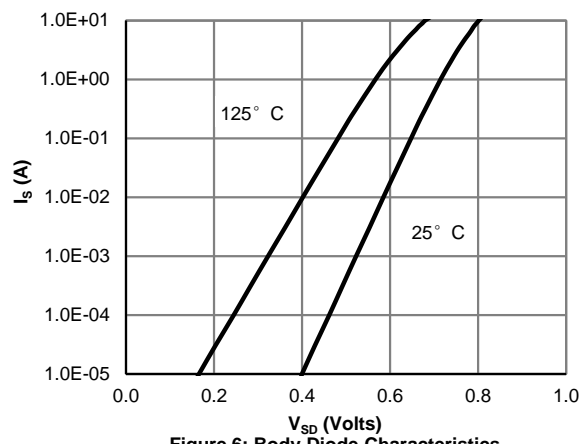
**Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)**



**Figure 4: On-Resistance vs. Junction Temperature (Note E)**

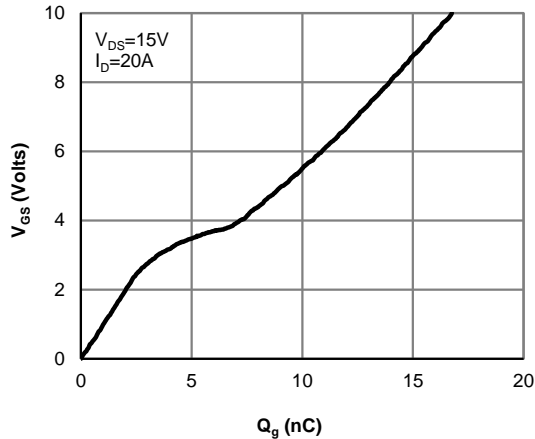


**Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)**

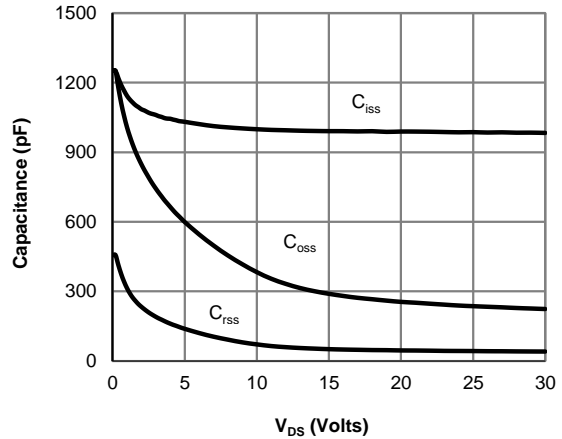


**Figure 6: Body-Diode Characteristics (Note E)**

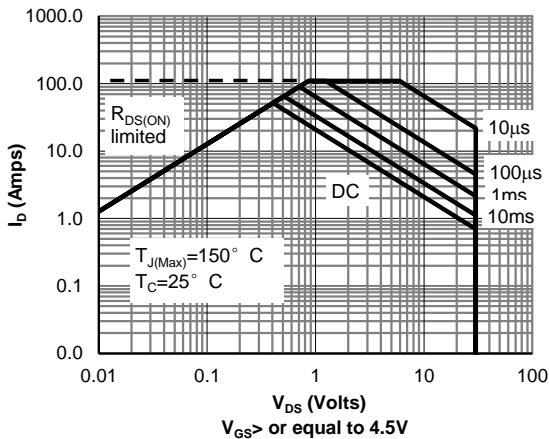
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



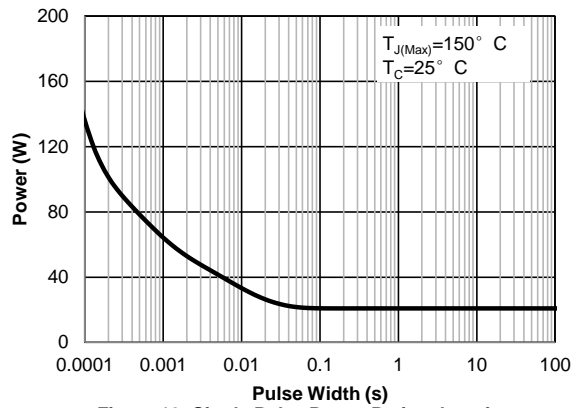
**Figure 7: Gate-Charge Characteristics**



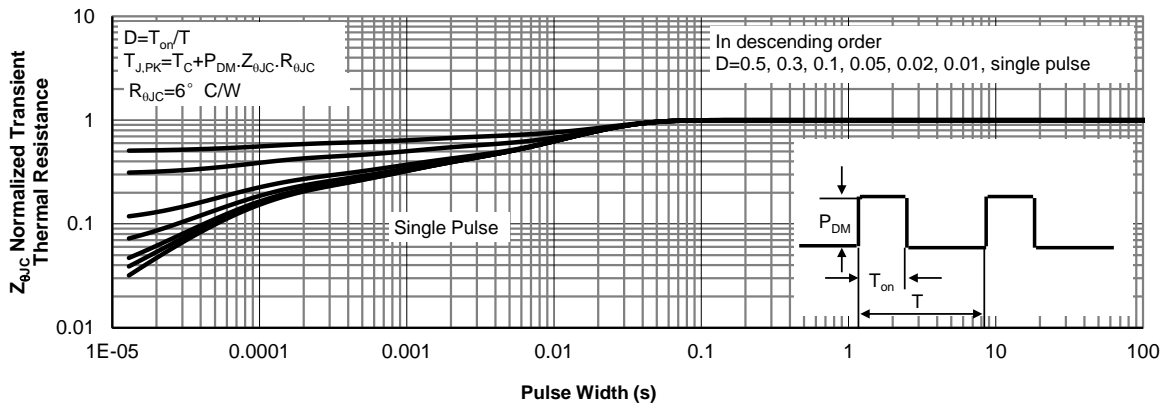
**Figure 8: Capacitance Characteristics**



**Figure 9: Maximum Forward Biased Safe Operating Area (Note F)**



**Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)**



**Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)**

**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

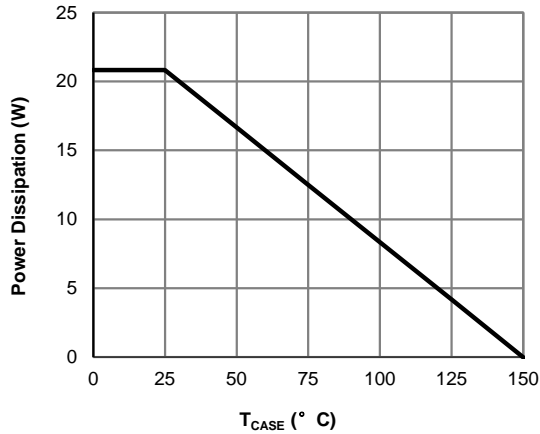


Figure 12: Power De-rating (Note F)

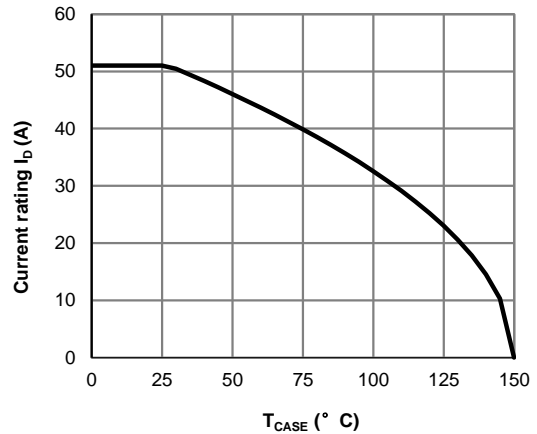


Figure 13: Current De-rating (Note F)

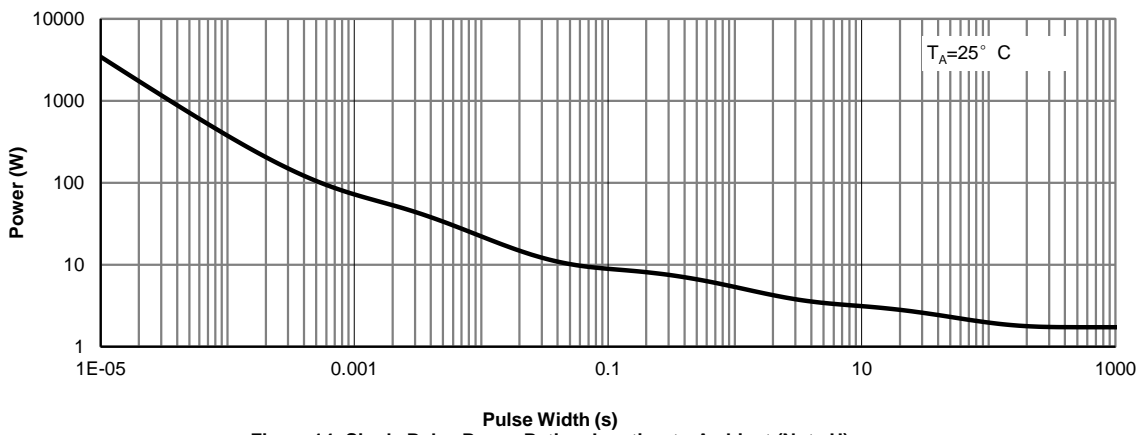


Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note H)

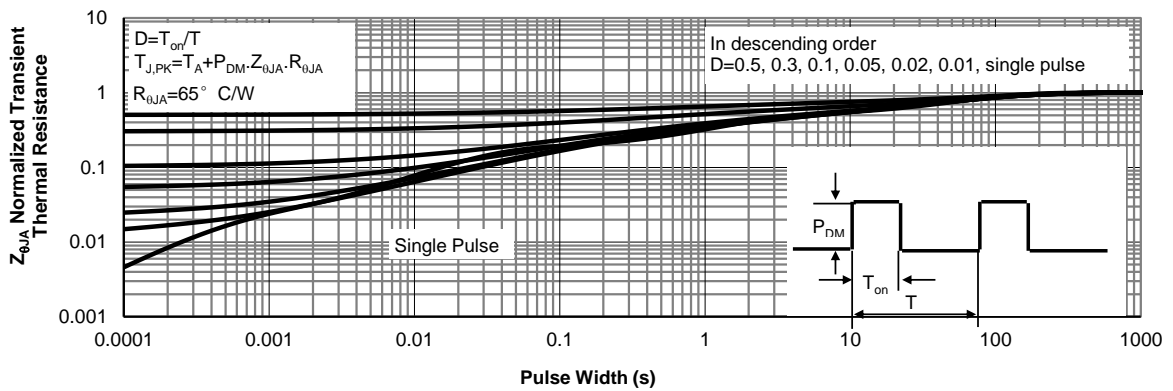


Figure 15: Normalized Maximum Transient Thermal Impedance (Note H)

**Q2 Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)**

| Symbol                      | Parameter                             | Conditions   | Min | Typ  | Max    | Units |
|-----------------------------|---------------------------------------|--|-----|------|--------|-------|
| <b>STATIC PARAMETERS</b>    |                                       |  |     |      |        |       |
| BV <sub>DSS</sub>           | Drain-Source Breakdown Voltage        | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V   | 30  |      |        | V     |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current       | V <sub>DS</sub> =30V, V <sub>GS</sub> =0V<br>T <sub>J</sub> =55°C                          |     |      | 1<br>5 | μA    |
| I <sub>GSS</sub>            | Gate-Body leakage current             | V <sub>DS</sub> =0V, V <sub>GS</sub> =±12V   |     |      | ±100   | nA    |
| V <sub>GS(th)</sub>         | Gate Threshold Voltage                | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA                                   | 1.1 | 1.5  | 1.9    | V     |
| R <sub>DS(ON)</sub>         | Static Drain-Source On-Resistance     | V <sub>GS</sub> =10V, I <sub>D</sub> =20A<br>T <sub>J</sub> =125°C                         |     | 2.1  | 2.8    | mΩ    |
|                             |                                       | V <sub>GS</sub> =4.5V, I <sub>D</sub> =20A   |     | 3.0  | 4.0    |       |
| g <sub>FS</sub>             | Forward Transconductance              | V <sub>DS</sub> =5V, I <sub>D</sub> =20A   |     | 165  |        | S     |
| V <sub>SD</sub>             | Diode Forward Voltage                 | I <sub>S</sub> =1A, V <sub>GS</sub> =0V  |     | 0.7  | 1      | V     |
| I <sub>S</sub>              | Maximum Body-Diode Continuous Current |  |     |      | 40     | A     |
| <b>DYNAMIC PARAMETERS</b>   |                                       |  |     |      |        |       |
| C <sub>iss</sub>            | Input Capacitance                     | V <sub>GS</sub> =0V, V <sub>DS</sub> =15V, f=1MHz  |     | 1890 |        | pF    |
| C <sub>oss</sub>            | Output Capacitance                    |  |     | 395  |        | pF    |
| C <sub>riss</sub>           | Reverse Transfer Capacitance          |  |     | 55   |        | pF    |
| R <sub>g</sub>              | Gate resistance                       | f=1MHz   | 1.2 | 2.3  | 3.6    | Ω     |
| <b>SWITCHING PARAMETERS</b> |                                       |  |     |      |        |       |
| Q <sub>g(10V)</sub>         | Total Gate Charge                     | V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, I <sub>D</sub> =20A                            |     | 27.5 | 40     | nC    |
| Q <sub>g(4.5V)</sub>        | Total Gate Charge                     |  |     | 11.5 | 18     | nC    |
| Q <sub>gs</sub>             | Gate Source Charge                    |  |     | 6    |        | nC    |
| Q <sub>gd</sub>             | Gate Drain Charge                     |  |     | 2.5  |        | nC    |
| t <sub>D(on)</sub>          | Turn-On Delay Time                    | V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, R <sub>L</sub> =0.75Ω,<br>R <sub>GEN</sub> =3Ω |     | 7.5  |        | ns    |
| t <sub>r</sub>              | Turn-On Rise Time                     |  |     | 3.5  |        | ns    |
| t <sub>D(off)</sub>         | Turn-Off Delay Time                   |  |     | 30   |        | ns    |
| t <sub>f</sub>              | Turn-Off Fall Time                    |  |     | 4    |        | ns    |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time      | I <sub>F</sub> =20A, di/dt=500A/μs   |     | 12   |        | ns    |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery Charge    | I <sub>F</sub> =20A, di/dt=500A/μs   |     | 21   |        | nC    |

A. The value of R<sub>θJA</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C. The Power dissipation P<sub>DSM</sub> is based on R<sub>θJA</sub> ≤ 10s and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design.

B. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature T<sub>J(MAX)</sub>=150° C.

D. The R<sub>θJA</sub> is the sum of the thermal impedance from junction to case R<sub>θJC</sub> and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150° C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

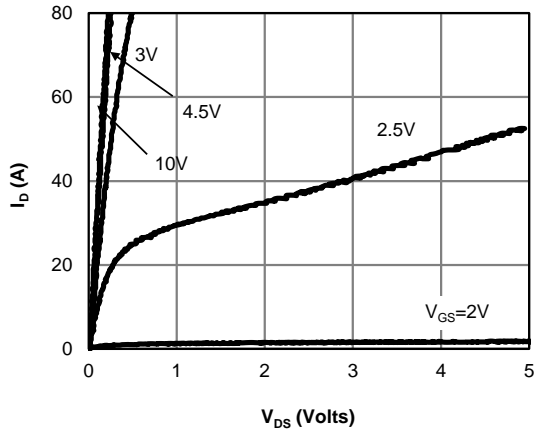
H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C.

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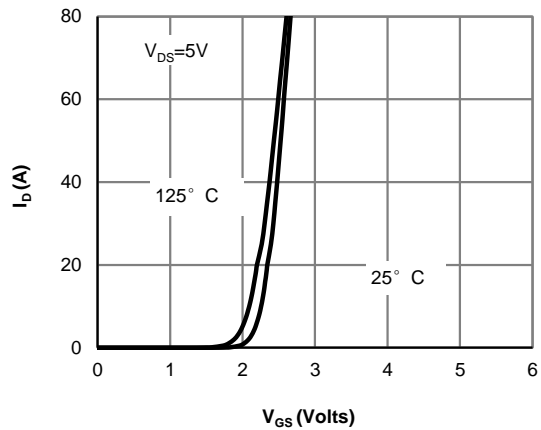
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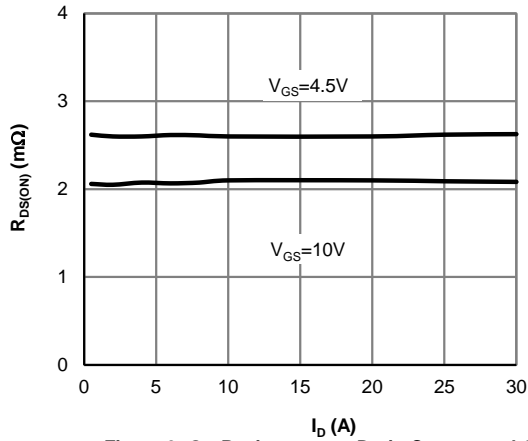
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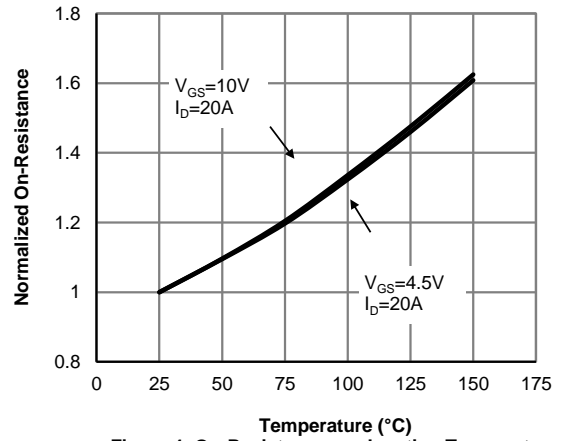
**Figure 1: On-Region Characteristics (Note E)**



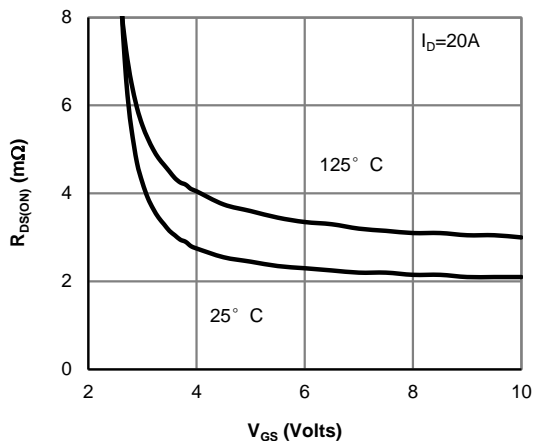
**Figure 2: Transfer Characteristics (Note E)**



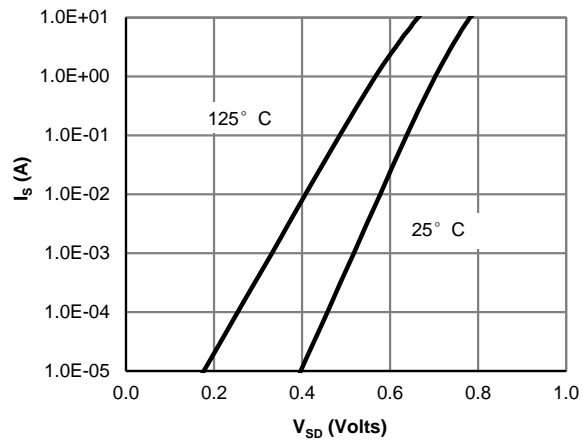
**Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)**



**Figure 4: On-Resistance vs. Junction Temperature (Note E)**

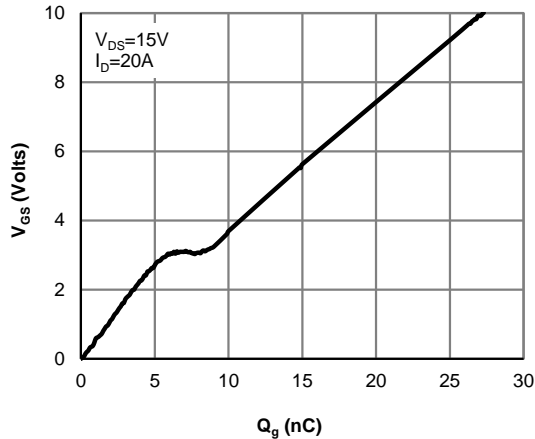


**Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)**

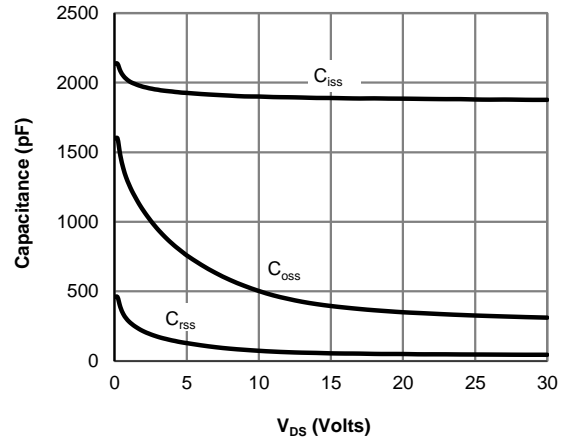


**Figure 6: Body-Diode Characteristics (Note E)**

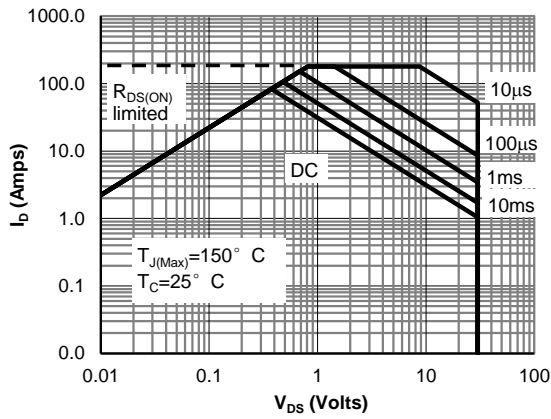
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



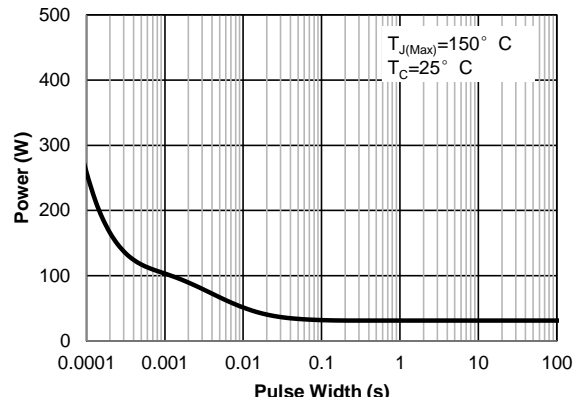
**Figure 7: Gate-Charge Characteristics**



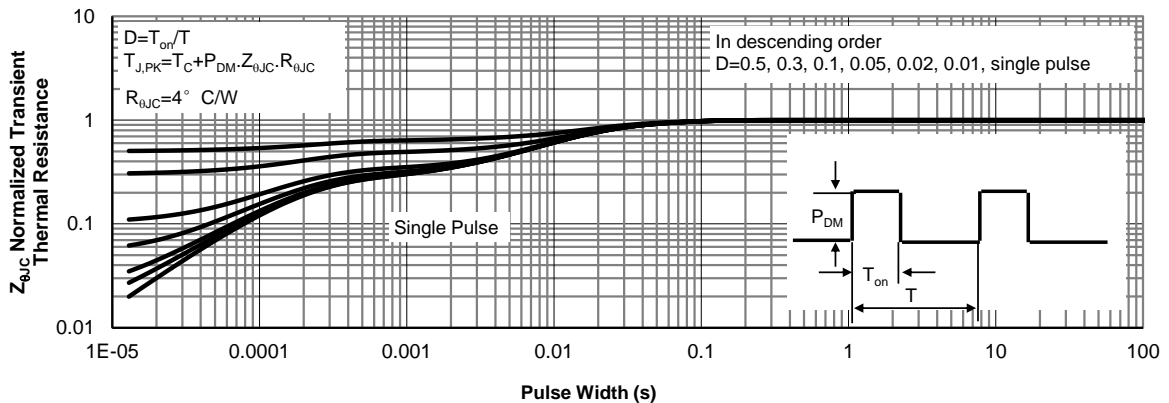
**Figure 8: Capacitance Characteristics**



**Figure 9: Maximum Forward Biased Safe Operating Area (Note F)**



**Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)**



**Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)**



**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

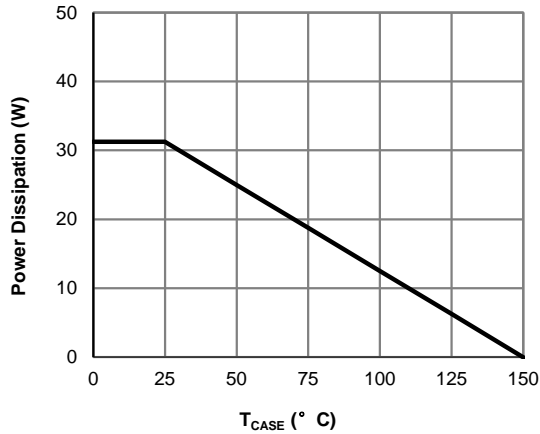


Figure 12: Power De-rating (Note F)

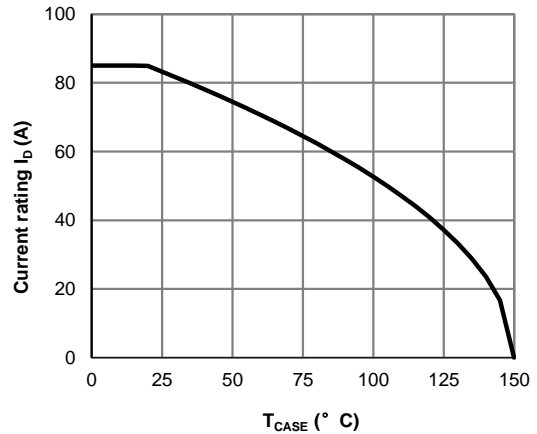


Figure 13: Current De-rating (Note F)

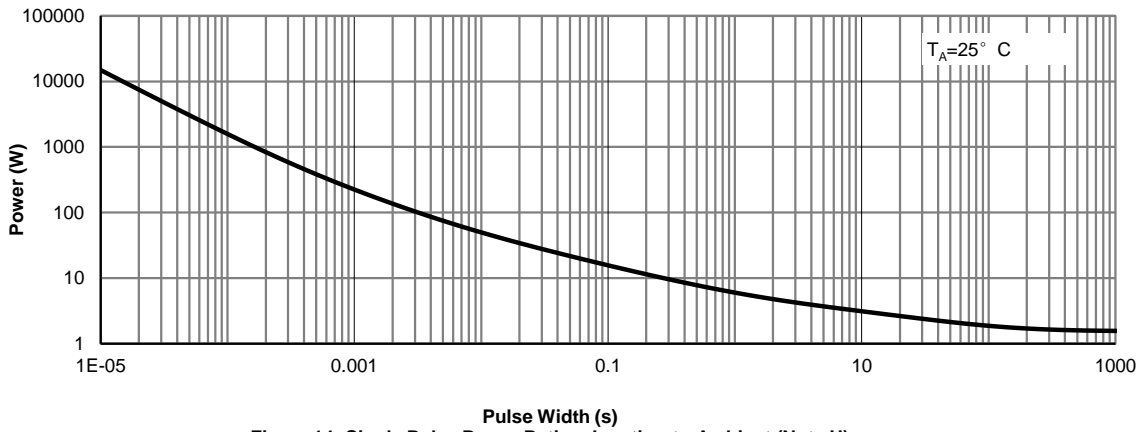


Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note H)

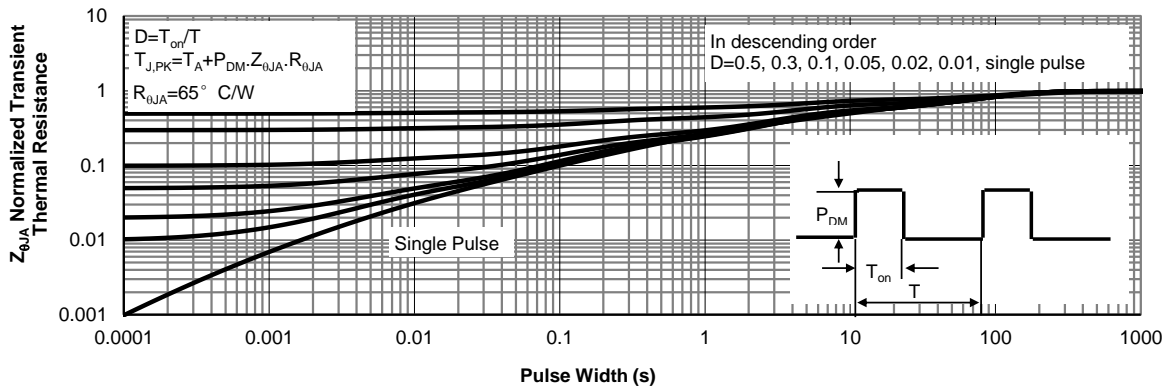


Figure 15: Normalized Maximum Transient Thermal Impedance (Note H)

Figure A: Gate Charge Test Circuit & Waveforms

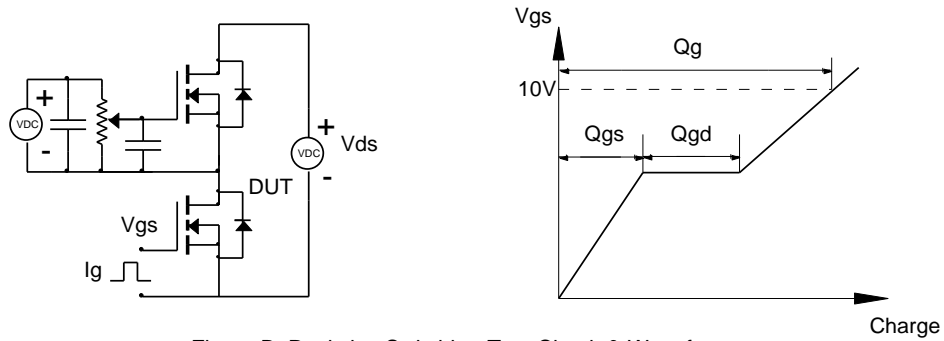


Figure B: Resistive Switching Test Circuit & Waveforms

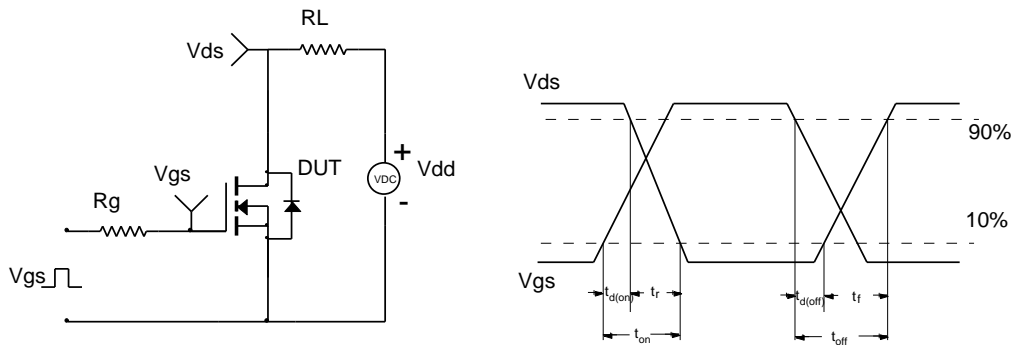


Figure C: Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

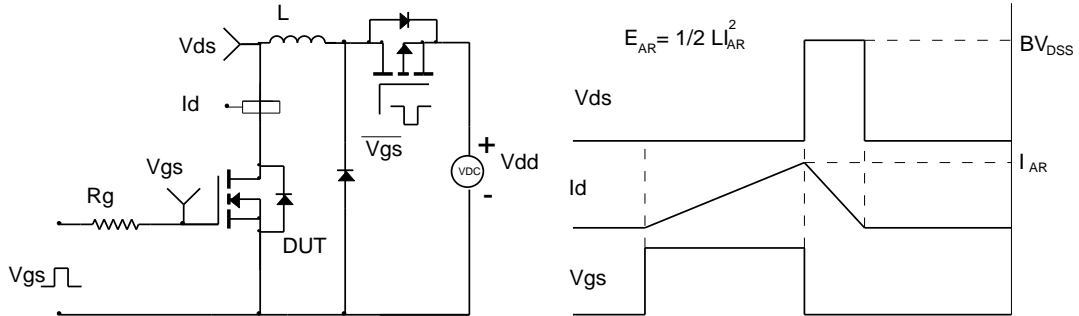
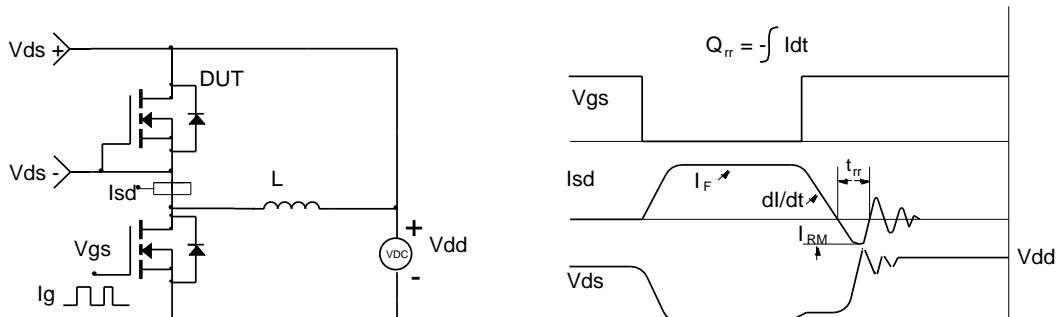


Figure D: Diode Recovery Test Circuit & Waveforms



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